

Search Notes

Application/Control No.

10/760,119

Examiner

Cephia D. Toomer

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

1714

SEARCHED

Class	Subclass	Date	Examiner
44	275	4/07	CD
431	288	07	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search EAST	4/07 1	CD